

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/679,782	ANGELOPOULOS ET AL.	
Examiner	Art Unit	
Sin J. Lee	1752	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Structure Search for Formula I-II in C1.#2	9-9 -05	27(
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